

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/778,961	YAN ET AL.
	Examiner	Art Unit
	Tekchand Saidha	1652

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
435	198		
	252.3		
	320.1	5/31/2005	TEK
<i>536</i>	<i>23-2</i>		
SEQ ID Nos. 1-3		5/31/2005	Tek